

Application/Control No.	Applicant(s)/Patent under Reexamination							
10/622,549	JAENECKE ET AL.							
Examiner	Art Unit							
Khanh Tran	2611							

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(Assistant Examiner) (Date)			KHANH C. TRAN 09/26/2007 PRIMARY EXAMINER					Total Claims Allowed: 12			.G.		
(Legalunsentriems Examiner) (Date)		(Primary Examiner) (Date)					Print Claim(s)			Print Fig.			
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